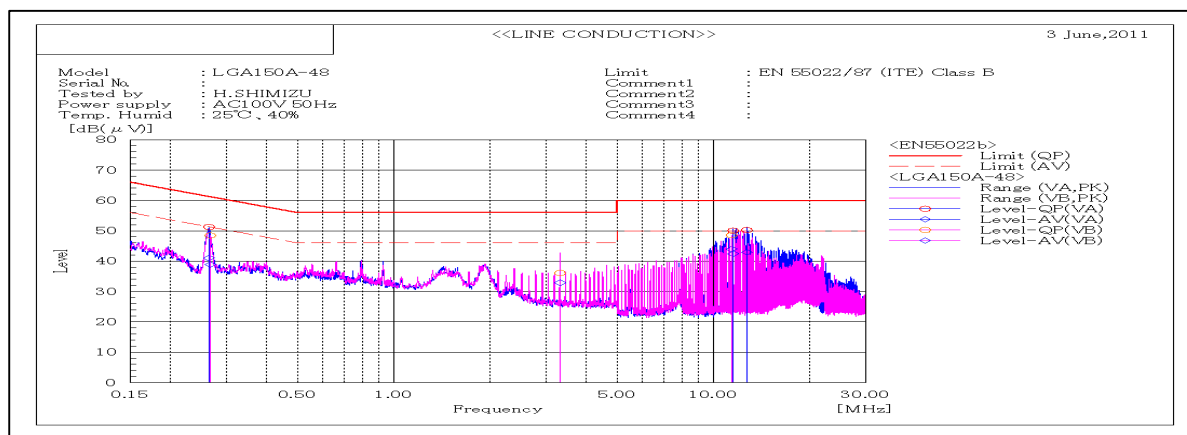
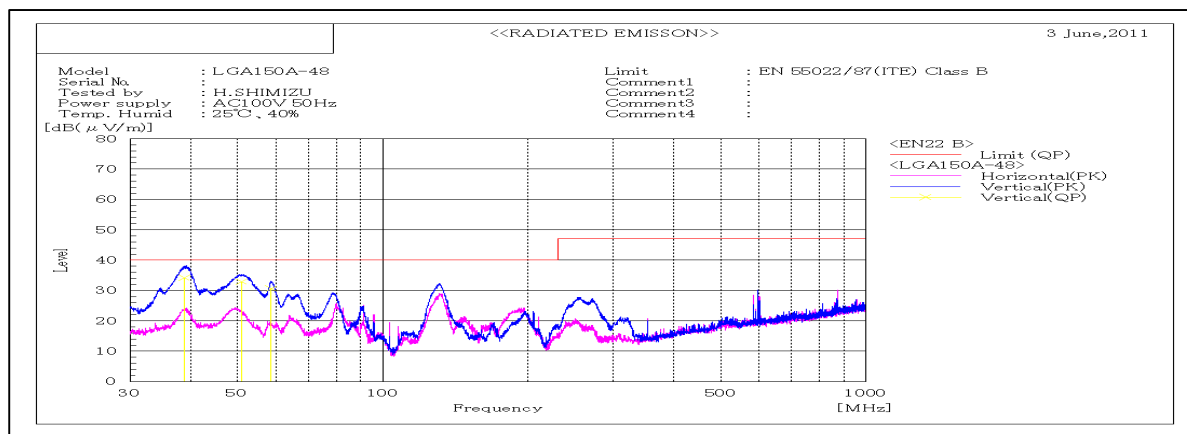


DATA SHEET

Model	LGA150A-48	Date	03-Jun-11
Test	EMI Line conduction & Radiated emission	Temp.	25 degreeC
		Humid.	40 %RH
		Tested by	H.SHIMIZU



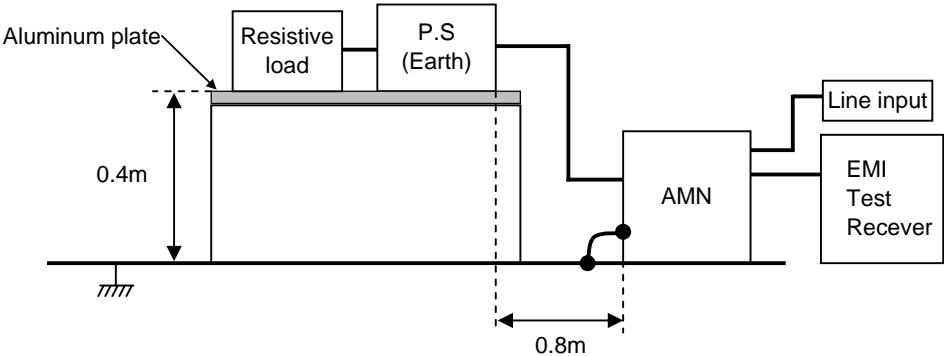
Frequency MHz	Line Phase	Reading dB(μV)		Factor dB	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/ Fail	Remark
		QP	AV		QP	AV	QP	AV	QP	AV		
0.2668	VB	38.3	28.7	10.2	48.5	38.9	61.2	51.2	12.7	12.3	Pass	
0.26408	VA	41	30.8	10.2	51.2	41	61.3	51.3	10.1	10.3	Pass	
3.31079	VB	25.6	22.4	10.5	36.1	32.9	56	46	19.9	13.1	Pass	
11.3888	VB	37.6	33	10.9	48.5	43.9	60	50	11.5	6.1	Pass	
11.51935	VA	39	31.4	11	50	42.4	60	50	10	7.6	Pass	
12.71395	VA	39.1	31.8	11.1	50.2	42.9	60	50	9.8	7.1	Pass	



Frequency MHz	Polarizat ion	Reading dB(μV)	Space Loss dB	Level dB(mW)	Limit dB(mW)	Margin dB	Pass/Fail	Height cm	Angle deg	Remark
				QP	QP	QP				
38.785	V	48.1	-14.1	34	40	6	Pass	138	245	
51.07	V	53.5	-20.6	32.9	40	7.1	Pass	124	249	
58.875	V	53.3	-22.7	30.6	40	9.4	Pass	100	0	

DATA SHEET		Date	03-Jun-11
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	H.SHIMIZU

1. Line conduction



2. Radiated emission

